


<b>Search Notes</b>  	<b>Application/Control No.</b>  09841266	<b>Applicant(s)/Patent Under Reexamination</b>  REYNAR, JEFF
	<b>Examiner</b>  CHAU NGUYEN	<b>Art Unit</b>  2176

SEARCHED			
Class	Subclass	Date	Examiner
715	200	03/05/2008	cn
715	206	03/05/2008	cn
715	230	03/05/2008	cn
715	231	03/05/2008	cn
715	232	03/05/2008	cn
715	233	03/05/2008	cn
715	234	03/05/2008	cn

SEARCH NOTES		
Search Notes	Date	Examiner
Updated Search on East Reports	03/03/2008	cn
	03/04/2008	cn
	03/05/2008	cn
	03/06/2008	cn
	03/11/2008	cn
Discussed with Primary William Bashore	03/06/2008	cn
Inventor Search for Double Patenting	03/04/2008	cn
NPL Search using IEEE Database	03/11/2008	cn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
715	200	03/05/2008	cn
715	206	03/05/2008	cn
715	230	03/05/2008	cn
715	231	03/05/2008	cn
715	232	03/05/2008	cn
715	233	03/05/2008	cn
715	234	03/05/2008	cn